Search Notes



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10/734,162

Examiner

Matthew Landau

Applicant(s)/Patent	unde
Reexaminat	tion	

PARK ET AL.

Art Unit

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SEARCHED			
Class	Subclass	Date	Examiner
257	64,70,75, E29,003	1/31/07	m
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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